

Title (en)

ANTIBACTERIAL MATERIAL AND ANTIBACTERIAL FILM AND ANTIBACTERIAL MEMBER USING THE SAME

Title (de)

ANTIBAKTERIELLES MATERIAL UND ANTIBAKTERIELLER FILM SOWIE ANTIBAKTERIELLES ELEMENT DAMIT

Title (fr)

MATÉRIAU ANTIBACTÉRIEN ET FILM ANTIBACTÉRIEN ET ARTICLE ANTIBACTÉRIEN UTILISANT CEUX-CI

Publication

EP 2255878 A4 20110928 (EN)

Application

EP 09717571 A 20090304

Priority

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Abstract (en)

[origin: EP2255878A1] An antibacterial material includes at least one microparticles selected from tungsten oxide microparticles and tungsten oxide complex microparticles. The microparticles, which are undergone a test to evaluate viable cell count by inoculating in a test piece, to which the microparticles are adhered in a range of 0.02 mg/cm² or more and 40 mg/cm² or less, at least one bacterium selected from among *Staphylococcus aureus*, *Escherichia coli*, *Klebsiella pneumoniae*, *Pseudomonas aeruginosa*, methicillin-resistant *Staphylococcus aureus*, and enterohemorrhagic *Escherichia coli*, and storing for 24 hours, have an antibacterial activity value R of 0.1 or more expressed by the following: R = log B₁ / C₁ (where, B₁ denotes an average value (number) of viable cell count after storing an untreated test piece for 24 hours, and C₁ denotes an average value (number) of viable cell count after storing the test piece on which the microparticles are coated for 24 hours).

IPC 8 full level

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